SCBS204C - JUNE 1992 - REVISED MAY 1997

- Members of the Texas Instruments Widebus™ Family
- State-of-the-Art EPIC-IIB™ BiCMOS Design Significantly Reduces Power Dissipation
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Latch-Up Performance Exceeds 500 mA Per JEDEC Standard JESD-17
- Typical V_{OLP} (Output Ground Bounce) < 1 V at V_{CC} = 5 V, T_A = 25°C
- High-Impedance State During Power Up and Power Down
- Distributed V_{CC} and GND Pin Configuration Minimizes High-Speed Switching Noise
- Flow-Through Architecture Optimizes PCB Layout
- High-Drive Outputs (-32-mA I_{OH}, 64-mA I_{OL})
- Bus Hold on Data Inputs Eliminates the Need for External Pullup/Pulldown Resistors
- Package Options Include Plastic 300-mil Shrink Small-Outline (DL) Package and 380-mil Fine-Pitch Ceramic Flat (WD) Package Using 25-mil Center-to-Center Spacings

description

The SN54ABT16260 and SN74ABTH16260 are 12-bit to 24-bit multiplexed D-type latches used in applications in which two separate data paths must be multiplexed onto, or demultiplexed from, a single data path. Typical applications include multiplexing and/or demultiplexing of address and data information in microprocessor or bus-interface applications. This device is also useful in memory-interleaving applications.

SN54ABT16260 ... WD PACKAGE SN74ABTH16260 ... DL PACKAGE (TOP VIEW)

| | Г | U | | |
|-------------------|----|---|----|------------------|
| OEA [| 1 | • | | OE2B |
| LE1B [| 2 | | 55 | LEA2B |
| 2B3 [| 3 | | 54 | 2B4 |
| GND [| 4 | | 53 | GND |
| 2B2 [| 5 | | 52 | 2B5 |
| 2B1 [| 6 | | 51 |] 2B6 |
| V _{CC} [| 7 | | 50 |]v _{cc} |
| A1 [| 8 | | 49 | 2B7 |
| A2 [| 9 | | 48 | 2B8 |
| A3 [| 10 | | 47 |] 2B9 |
| GND [| 11 | | 46 | GND |
| A4 [| 12 | | 45 | 2B10 |
| A5 [| 13 | | 44 | 2B11 |
| A6 [| 14 | | 43 |]2B12 |
| A7 [| 15 | | 42 |] 1B12 |
| A8 [| 16 | | 41 |] 1B11 |
| A9 [| 17 | | 40 |]1B10 |
| GND [| 18 | | 39 |] GND |
| A10 [| 19 | | 38 |] 1B9 |
| A11 [| 20 | | 37 |] 1B8 |
| A12 [| 21 | | 36 |] 1B7 |
| v _{cc} [| 22 | | 35 |]v _{cc} |
| 1B1 [| 23 | | 34 | |
| 1B2 [| 24 | | 33 |] 1B5 |
| GND [| 25 | | 32 | GND |
| 1B3 [| 26 | | 31 |]1B4 |
| LE2B [| 27 | | 30 | LEA1B |
| SEL[| 28 | | 29 | OE1B |

Three 12-bit I/O ports (A1-A12, 1B1-1B12, and 2B1-2B12) are available for address and/or data transfer. The output-enable (OE1B, OE2B, and OEA) inputs control the bus-transceiver functions. The OE1B and OE2B control signals also allow bank control in the A-to-B direction.

Address and/or data information can be stored using the internal storage latches. The latch-enable (LE1B, LE2B, LEA1B, and LEA2B) inputs are used to control data storage. When the latch-enable input is high, the latch is transparent. When the latch-enable input goes low, the data present at the inputs is latched and remains latched until the latch-enable input is returned high.



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SCBS204C - JUNE 1992 - REVISED MAY 1997

description (continued)

When V_{CC} is between 0 and 2.1 V, the device is in the high-impedance state during power up or power down. However, to ensure the high-impedance state above 2.1 V, \overline{OE} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

Active bus-hold circuitry is provided to hold unused or floating data inputs at a valid logic level.

The SN54ABT16260 is characterized for operation over the full military temperature range of –55°C to 125°C. The SN74ABTH16260 is characterized for operation from –40°C to 85°C.

Function Tables

B TO A $(\overline{OEB} = H)$

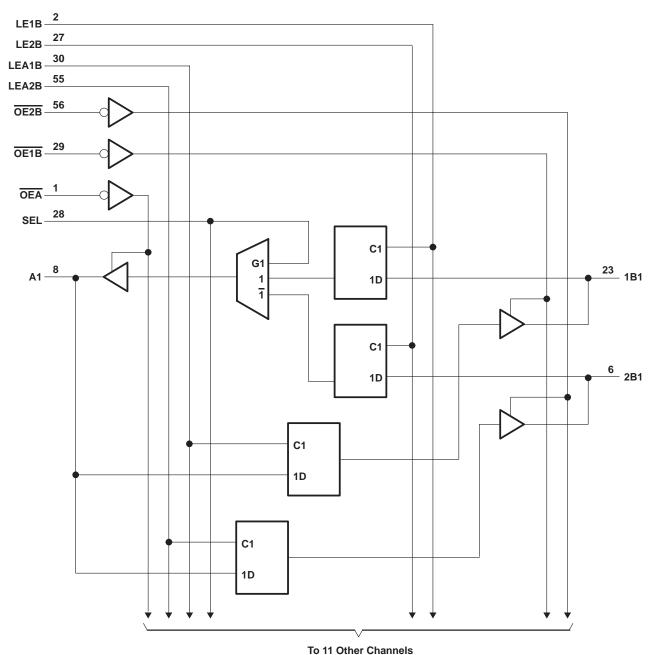
| | OUTPUT | | | | | |
|----|--------|-----|------|------|-----|----------------|
| 1B | 2B | SEL | LE1B | LE2B | OEA | Α |
| Н | Χ | Н | Н | Х | L | Н |
| L | Χ | Н | Н | X | L | L |
| Х | Χ | Н | L | Χ | L | A ₀ |
| Х | Н | L | X | Н | L | Н |
| Х | L | L | X | Н | L | L |
| Х | Χ | L | Χ | L | L | A ₀ |
| Х | Χ | Χ | X | X | Н | Z |

A TO B ($\overline{OEA} = H$)

| 7110 2 (0 2 2 1 - 1 1) | | | | | | | | | | |
|------------------------|-------|---------|------|------|-----------------|-----------------|--|--|--|--|
| | | OUTPUTS | | | | | | | | |
| Α | LEA1B | LEA2B | OE1B | OE2B | 1B | 2B | | | | |
| Н | Н | Н | L | L | Н | Н | | | | |
| L | Н | Н | L | L | L | L | | | | |
| Н | Н | L | L | L | Н | 2B ₀ | | | | |
| L | Н | L | L | L | L | 2B ₀ | | | | |
| Н | L | Н | L | L | 1B ₀ | Н | | | | |
| L | L | Н | L | L | 1B ₀ | L | | | | |
| Χ | L | L | L | L | 1B ₀ | 2B ₀ | | | | |
| Χ | X | Χ | Н | Н | Z | Z | | | | |
| Χ | X | Χ | L | Н | Active | Z | | | | |
| Χ | X | Χ | Н | L | Z | Active | | | | |
| Χ | Х | Χ | L | L | Active | Active | | | | |

SCBS204C - JUNE 1992 - REVISED MAY 1997

logic diagram (positive logic)



SCBS204C - JUNE 1992 - REVISED MAY 1997

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

| Supply voltage range, V _{CC} | 0.5 V to 7 V |
|------------------------------------------------------------------------|----------------|
| Input voltage range, V _I (see Note 1) | 0.5 V to 7 V |
| Voltage range applied to any output in the high or power-off state, VO | |
| Current into any output in the low state, IO: SN54ABT16260 | 96 mA |
| SN74ABTH16260 | |
| Input clamp current, I _{IK} (V _I < 0) | –18 mA |
| Output clamp current, I _{OK} (V _O < 0) | –50 mA |
| Package thermal impedance, θ _{JA} (see Note 2): DL package | 74°C/W |
| Storage temperature range, T _{stq} | –65°C to 150°C |

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions (see Note 3)

| | | | SN54AB | Г16260 | SN74ABTI | H16260 | UNIT |
|---------------------|------------------------------------|-----------------|--------|--------|----------|--------|------|
| | | | MIN | MAX | MIN | MAX | UNIT |
| Vcc | Supply voltage | | 4.5 | 5.5 | 4.5 | 5.5 | V |
| VIH | High-level input voltage | | 2 | | 2 | | V |
| V _{IL} | Low-level input voltage | | | 0.8 | | 0.8 | V |
| VI | Input voltage | | 0 | VCC | 0 | Vcc | V |
| loн | High-level output current | | | -24 | | -32 | mA |
| loL | Low-level output current | | | 48 | | 64 | mA |
| Δt/Δν | Input transition rise or fall rate | Outputs enabled | | 10 | | 10 | ns/V |
| Δt/ΔV _{CC} | Power-up ramp rate | | 200 | | 200 | | μs/V |
| T _A | Operating free-air temperature | | -55 | 125 | -40 | 85 | °C |

NOTE 3: Unused control inputs must be held high or low to prevent them from floating.



NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

^{2.} The package thermal impedance is calculated in accordance with EIA/JEDEC Std JESD51.

SCBS204C - JUNE 1992 - REVISED MAY 1997

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | | TEST COM | DITIONS | Т | T _A = 25°C SN54ABT16260 SN74ABT | | SN74ABTH | 116260 | UNIT | | |
|---------------------|----------------|--------------------------------------------------------------------------------------------------------------|----------------------------------|-----|--------------------------------------------|-------|----------|--------|------|------|------|
| PARA | AIVIETER | TEST CON | DITIONS | MIN | TYP [†] | MAX | MIN | MAX | MIN | MAX | UNII |
| VIK | | $V_{CC} = 4.5 \text{ V},$ | $I_{I} = -18 \text{ mA}$ | | | -1.2 | | -1.2 | | -1.2 | V |
| | | $V_{CC} = 4.5 \text{ V},$ | $I_{OH} = -3 \text{ mA}$ | 2.5 | | | 2.5 | | 2.5 | | |
| Vон | | $V_{CC} = 5 V$, | $I_{OH} = -3 \text{ mA}$ | 3 | | | 3 | | 3 | | V |
| VОН | | V _{CC} = 4.5 V | $I_{OH} = -24 \text{ mA}$ | 2 | | | 2 | | | | V |
| | | VCC = 4.5 V | $I_{OH} = -32 \text{ mA}$ | 2* | | | | | 2 | | |
| VOL | | V _{CC} = 4.5 V | $I_{OL} = 48 \text{ mA}$ | | 0.36 | | | 0.5 | | | V |
| VOL | | VCC = 4.5 V | I _{OL} = 64 mA | | | 0.55* | | | | 0.55 | V |
| V_{hys} | | | | | 100 | | | | | | mV |
| L | Control inputs | $V_{CC} = 0$ to 5.5 V, $V_{I} = V_{CC}$ or GND | | | | ±1 | | ±1 | | ±1 | A |
| l _l | A or B ports | $V_{CC} = 2.1 \text{ V to } 5.5 \text{ V}$ $V_{I} = V_{CC} \text{ or GND}$ | /, | | | ±20 | | ±100 | | ±20 | μΑ |
| ha . i s | A or B ports | V _{CC} = 4.5 V | V _I = 0.8 V | | | | 100 | | 100 | | μА |
| l(hold) | A of B ports | VCC = 4.5 V | V _I = 2 V | | | | -100 | | -100 | | μΛ |
| I _{OZPU} ‡ | | $V_{CC} = 0 \text{ to } 2.1 \text{ V},$ $V_{O} = 0.5 \text{ V to } 2.7 \text{ V},$ | OE = X | | | ±50 | | ±50 | | ±50 | μΑ |
| lozpd‡ | | $V_{CC} = 2.1 \text{ V to 0},$ $V_{O} = 0.5 \text{ V to 2.7 V},$ | OE = X | | | ±50 | | ±50 | | ±50 | μΑ |
| I _{OZH} § | | $V_{CC} = 2.1 \text{ V to } 5.5 \text{ V}$ $V_{O} = 2.7 \text{ V}, \overline{OE} \ge 2 \text{ V}$ | /, / | | | 10 | | 10 | | 10 | μΑ |
| I _{OZL} § | | $V_{CC} = 2.1 \text{ V} \text{ to } 5.5 \text{ V}$ $V_{O} = 0.5 \text{ V}, \overline{OE} \ge 2 \text{ V}$ | | | | -10 | | -10 | | -10 | μΑ |
| l _{off} | | $V_{CC} = 0$, | V_I or $V_O \le 4.5 \text{ V}$ | | | ±100 | | | | ±100 | μΑ |
| ICEX | | V _{CC} = 5.5 V, V _O = 5.5 V | Outputs high | | | 50 | | 50 | | 50 | μΑ |
| ΙΟ [¶] | | V _{CC} = 5.5 V, | V _O = 2.5 V | -50 | -100 | -225 | -50 | -225 | -50 | -225 | mA |
| | | V _{CC} = 5.5 V, | Outputs high | | | 1.5 | | 1.5 | | 1.5 | |
| ICC | | $I_{O} = 0$, | Outputs low | | | 63 | | 63 | | 63 | mA |
| | | $V_I = V_{CC}$ or GND | Outputs disabled | | | 1 | | 1 | | 1 | |
| ∆lcc [#] | | $V_{CC} = 5.5 \text{ V}$, One in Other inputs at V_{CC} | | | | 1.5 | | 1.5 | | 1.5 | mA |
| Ci | | V _I = 2.5 V or 0.5 V | | | 3 | | | | | | pF |
| C _{io} | | V _O = 2.5 V or 0.5 V | | | 11.5 | | | | | | pF |

^{*} On products compliant to MIL-PRF-38535, this parameter does not apply.



[†] All typical values are at V_{CC} = 5 V. ‡ This parameter is characterized, but not production tested.

[§] The parameters I_{OZH} and I_{OZL} include the input leakage current.

¶ Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

[#]This is the increase in supply current for each input that is at the specified TTL voltage level rather than VCC or GND.

SCBS204C - JUNE 1992 - REVISED MAY 1997

timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

| | | V _{CC} = 5 V, T _A = 25°C† | | SN54AB1 | T16260 SN74ABTH16260 | | | UNIT |
|-----------------|------------------------------------------------------------------|--------------------------------------------------|-----|---------|----------------------|-----|-----|------|
| | | MIN | MAX | MIN | MAX | MIN | MAX | |
| t _W | Pulse duration, LE1B, LE2B, LEA1B, or LEA2B high | 3.3 | | 3.3 | | 3.3 | | ns |
| t _{su} | Setup time, data before LE1B, LE2B, LEA1B, or LEA2B \downarrow | 1.5 | | 2 | | 1.5 | | ns |
| th | Hold time, data after LE1B, LE2B, LEA1B, or LEA2B↓ | 1 | | 1.5 | | 1 | | ns |

[†] These values apply only to the SN74ABTH16260.

switching characteristics over recommended ranges of supply voltage and operating free-air temperature, $C_L = 50$ pF (unless otherwise noted) (see Figure 1)

| | | | | SN5 | 4ABT16 | 260 | | |
|------------------|-----------------|----------------|----------|-----|-------------------------------------------------|-----|-----|--------|
| PARAMETER | FROM (INPUT) | TO (OUTPUT) | 1 00 / 1 | | V _{CC} = 5 V, T _A = 25°C | | | UNIT |
| | | | MIN | TYP | MAX | | | |
| t _{PLH} | A or B | B or A | 1 | 3.1 | 5.3 | 1 | 5.9 | ns |
| t _{PHL} | AOIB | BULA | 1 | 3.4 | 5.4 | 1 | 6.3 | 115 |
| ^t PLH | LE | A or B | 1.1 | 3.2 | 5.4 | 1.1 | 6.6 | ns |
| t _{PHL} | | 1 | 1.1 | 3.3 | 5.3 | 1.1 | 5.9 | 115 |
| 4 | SEL (B1) | | 1.3 | 3.2 | 5.1 | 1.3 | 5.4 | |
| ^t PLH | SEL (B2) | А | 1.1 | 3.4 | 5.4 | 1.1 | 6.3 | 6.3 ns |
| tou | SEL (B1) | ^ | 1.5 | 3.1 | 4.6 | 1.5 | 5 | |
| ^t PHL | SEL (B2) | | 1.6 | 3.6 | 5.3 | 1.6 | 6.2 | |
| ^t PZH | | A or B | 1 | 3.3 | 5.6 | 1 | 6.4 | |
| tPZL | ŌE A | AUID | 1.6 | 3.8 | 5.9 | 1.6 | 6.5 | ns |
| ^t PHZ | ŌĒ | A or B | 2.2 | 4.1 | 5.9 | 2.2 | 7.5 | |
| t _{PLZ} | OE . | AUID | 1.3 | 3.2 | 5 | 1.3 | 5.4 | ns |

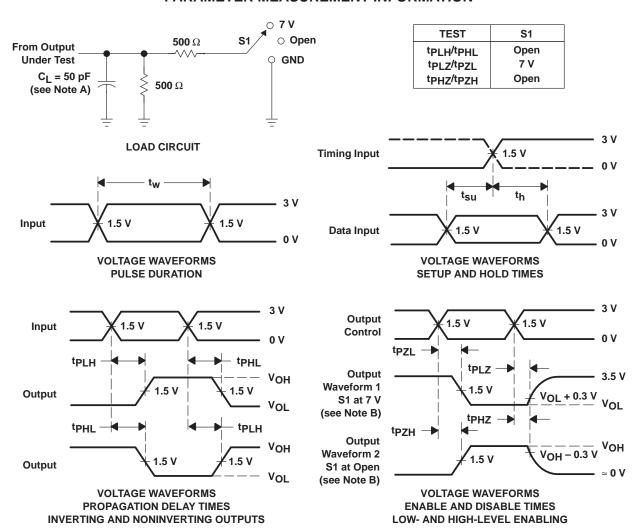
switching characteristics over recommended ranges of supply voltage and operating free-air temperature, $C_L = 50$ pF (unless otherwise noted) (see Figure 1)

| | | | | SN74 | ABTH1 | 6260 | | |
|------------------|-----------------|----------------|-------------------------------------------------|------|-------|------|-----|------|
| PARAMETER | FROM (INPUT) | TO (OUTPUT) | V _{CC} = 5 V, T _A = 25°C | | | MIN | MAX | UNIT |
| | | | MIN | TYP | MAX | | | |
| t _{PLH} | A or B | B or A | 1 | 3.1 | 4.8 | 1 | 5.6 | ns |
| t _{PHL} | A OL R | BULK | 1 | 3.4 | 5 | 1 | 5.9 | 115 |
| t _{PLH} | LE | A or B | 1.1 | 3.2 | 4.9 | 1.1 | 5.8 | 20 |
| ^t PHL | | 1 | 1.1 | 3.3 | 4.9 | 1.1 | 5.3 | ns |
| t | SEL (B1) | | 1.3 | 3.2 | 4.6 | 1.3 | 5.3 | |
| ^t PLH | SEL (B2) | Δ. | 1.1 | 3.4 | 4.9 | 1.1 | 6 | |
| 4 | SEL (B1) | А | 1.5 | 3.1 | 4.4 | 1.5 | 4.4 | ns |
| ^t PHL | SEL (B2) | | 1.6 | 3.6 | 5.1 | 1.6 | 5.9 | |
| ^t PZH | | A B | 1 | 3.3 | 4.7 | 1 | 5.7 | 20 |
| tPZL | ŌĒ | A or B | 1.6 | 3.8 | 5.1 | 1.6 | 5.8 | ns |
| ^t PHZ | ŌĒ | A or B | 2.2 | 4.1 | 5.4 | 2.2 | 6.4 | ne |
| t _{PLZ} | OE . | AUID | 1.3 | 3.2 | 4.4 | 1.3 | 4.8 | ns |



SCBS204C - JUNE 1992 - REVISED MAY 1997

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_O = 50~\Omega$, $t_f \leq$ 2.5 ns, $t_f \leq$ 2.5 ns.
- D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

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